

Delay testing of asynchronous NoC interconnects

Bengtsson, Tomas; **Jutman, Artur**; Kumar, Shashi; **Ubar, Raimund-Johannes** Proceedings of the 12th International Conference : Mixed Design of Integrated Circuits and Systems : MIXDES 2005 : Krakow, Poland, 22-25 June, 2005. Vol. 1 of 2 2005 / p. 419-424 : ill

Testing tools for training and education

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